Integrated autocorrelator based on superconducting nanowires

Published in:
Optics Express

DOI:
10.1364/OE.21.011162

Published: 01/01/2013

Document Version
Publisher’s PDF, also known as Version of Record (includes final page, issue and volume numbers)

Please check the document version of this publication:

• A submitted manuscript is the author's version of the article upon submission and before peer-review. There can be important differences between the submitted version and the official published version of record. People interested in the research are advised to contact the author for the final version of the publication, or visit the DOI to the publisher’s website.
• The final author version and the galley proof are versions of the publication after peer review.
• The final published version features the final layout of the paper including the volume, issue and page numbers.

Link to publication

Citation for published version (APA):
Sahin, D., Gaggero, A., Hoang, T. B., Frucci, G., Mattioli, F., Leoni, R., ... Fiore, A. (2013). Integrated autocorrelator based on superconducting nanowires. Optics Express, 21(9), 11162-11170. DOI: 10.1364/OE.21.011162

General rights
Copyright and moral rights for the publications made accessible in the public portal are retained by the authors and/or other copyright owners and it is a condition of accessing publications that users recognise and abide by the legal requirements associated with these rights.

• Users may download and print one copy of any publication from the public portal for the purpose of private study or research.
• You may not further distribute the material or use it for any profit-making activity or commercial gain
• You may freely distribute the URL identifying the publication in the public portal

Take down policy
If you believe that this document breaches copyright please contact us providing details, and we will remove access to the work immediately and investigate your claim.

Download date: 15. Dec. 2018
Integrated autocorrelator based on superconducting nanowires

Döndü Sahin,1,* Alessandro Gaggero,2 Thang Ba Hoang,1 Giulia Frucci,1 Francesco Mattioli,1 Roberto Leoni,2 Johannes Beetz,3 Matthias Lermer,3 Martin Kamp,3 Sven Höfling,3 and Andrea Fiore1

1COBRA Research Institute, Eindhoven University of Technology, PO Box 513, 5600 MB Eindhoven, The Netherlands
2Istituto di Fotonica e Nanotecnologie, CNR, via Cineto Romano 42, 00156 Roma, Italy
3Technische Physik, Julius-Maximilians-Universität Würzburg, Physikalisches Institut and Wilhelm Conrad Röntgen-Center for Complex Material Systems, Am Hubland, 97074 Würzburg, Germany
*d.sahin@tue.nl

Abstract: We demonstrate an integrated autocorrelator based on two superconducting single-photon detectors patterned on top of a GaAs ridge waveguide. This device enables the on-chip measurement of the second-order intensity correlation function \(g^{(2)}(\tau)\). A polarization-independent device quantum efficiency in the 1% range is reported, with a timing jitter of 88 ps at 1300 nm. \(g^{(2)}(\tau)\) measurements of continuous-wave and pulsed laser excitations are demonstrated with no measurable crosstalk within our measurement accuracy.

©2013 Optical Society of America

OCIS codes: (130.3120) Integrated optics devices; (270.5570) Quantum detectors.

References and links

For advancing quantum photonics, the integration of optical components, such as single photon sources [1–4], passive circuit elements [5] and single photon detectors [6–10], within a quantum photonic integrated circuit (QPIC) is required in order to scale the system up to few tens of photons, which would be for example required to perform quantum simulations [11]. The measurement of the second-order correlation function $g^{(2)}(\tau)$ and of the photon number is a key functionality for such a QPIC, allowing for example the characterization of single- and entangled-photon states [12]. The second-order autocorrelation function is usually measured in free space or fiber-optics with a Hanbury-Brown and Twiss interferometer [13], using a $\tau$-aligned photon-number-resolving detector at telecom wavelength, Nat. Photonics 2(5), 302–306 (2008).

1. Introduction

For advancing quantum photonics, the integration of optical components, such as single photon sources [1–4], passive circuit elements [5] and single photon detectors [6–10], within a quantum photonic integrated circuit (QPIC) is required in order to scale the system up to few tens of photons, which would be for example required to perform quantum simulations [11]. The measurement of the second-order correlation function $g^{(2)}(\tau)$ and of the photon number is a key functionality for such a QPIC, allowing for example the characterization of single- and entangled-photon states [12]. The second-order autocorrelation function is usually measured in free space or fiber-optics with a Hanbury-Brown and Twiss interferometer [13], using a $\tau$-aligned photon-number-resolving detector at telecom wavelength, Nat. Photonics 2(5), 302–306 (2008).

In this work, we apply a similar concept in an integrated platform and demonstrate an intensity autocorrelator based on two superconducting nanowires sensing the evanescent field of the same waveguide mode. This enables the measurement of the $g^{(2)}(\tau)$ with a very compact integrated device and represents the first step towards integrated photon-number-resolving detectors [15,16]. We report the polarization-independent response of the integrated nanowires and a detailed study of their mutual coupling, showing no measurable static and dynamic crosstalk.
2. Concept, design and fabrication

Figure 1(a) (sketch) shows the schematics of the integrated autocorrelators on a GaAs (0.35 μm)/Al_{0.75}Ga_{0.25}As (1.5 μm) waveguide heterostructure. There are two pairs of equidistant NbN nanowires on top of the waveguide, each with a width of 100 nm, a length of 50 μm and a spacing of 150 nm. Each pair of nanowires is separately connected to a bias and amplification circuit. The two pairs therefore constitute two independent superconducting single-photon detectors. The detectors exploit the hotspot mechanism for photon detection [17]. A single absorbed infrared photon breaks a Cooper pair which, through a subsequent relaxation process, creates a non-equilibrium population of quasi-particles. The resulting perturbation can produce a resistive cross-section in the wire, which diverts the bias current to a parallel load resistor, producing a voltage pulse.

The symmetric design assures the equal coupling of the waveguide mode with the two pairs of nanowires on the waveguide. The GaAs core layer is etched down by 300 nm to create a 1.85 μm-wide ridge waveguide that confines the quasi-transverse electric (TE) and transverse magnetic (TM) modes. In our simulations, we consider a 100 nm-thick SiO\(_x\) layer that is left as a residue of the hydrogen silsesquioxane (HSQ) on top of the NbN nanowires after the patterning of the nanowires. The modal absorption coefficients calculated with a finite-element solver (Comsol Multiphysics) are \(\alpha_{\text{TE}} = 542 \ \text{cm}^{-1}\) and \(\alpha_{\text{TM}} = 758 \ \text{cm}^{-1}\) for the lowest-order quasi-TE and quasi-TM modes (assuming a 5.9 nm-thick NbN layer and a refractive index \(n_{\text{NbN}} = 5.23 - 5.82i\) [18]), respectively. That allows 93% TE and 98% TM mode absorptance along a 50 μm-long waveguide.

A GaAs /Al_{0.75}Ga_{0.25}As heterostructure is grown by molecular beam epitaxy on top of an undoped GaAs (001) substrate. On the GaAs epi-layer, a 5.9 nm-thick NbN superconducting film is grown by a DC magnetron reactive sputtering technique in an Ar + N\(_2\) ambient at a nominal temperature of 415 °C with a critical temperature of \(T_c = 10.1\ \text{K}\) and a transition width of \(\Delta T_c = 0.5\ \text{K}\) [19]. The \(T_c\) and \(\Delta T_c\) are determined using the average and the difference of the temperatures corresponding to 90% and 10% of the average normal resistance derived following the procedure in Ref [20]. The autocorrelators are fabricated using four steps of direct-writing electron beam lithography (EBL). In the first step Ti(10nm)/Au(60nm) contact pads (patterned as a 50 Ω coplanar transmission line) and alignment markers are defined on positive tone PMMA electronic resist by lift-off. In the second step, the meander pattern is defined on a 140 nm-thick HSQ mask. The pattern is then transferred to the NbN film with a (CH\(_F_3\) + SF\(_6\) + Ar) reactive ion etching (RIE). The
patterning of the NbN nanowires (width of 100 nm, pitch of 250 nm), still covered with the HSQ mask, is very regular with a width uniformity of about 5%. In the third step we define HSQ-mask for the waveguide etching by carefully realigning this layer with the previous one. Successively, 300 nm of the underlying GaAs layer is etched with a Cl₂ + Ar electron cyclotron resonance technique. Finally, in order to allow the wiring to the TiAu electric contacts, holes through the residual HSQ-mask are opened using a PMMA mask and RIE in CHF₃ plasma. A scanning electron microscope (SEM) image of the fabricated autocorrelators is shown in Fig. 1(b).

3. Performance of waveguide autocorrelators

The experiments on waveguide autocorrelators are performed in a continuous flow cryogenic probe station with a base temperature of 2.1 K on the sample holder. A lensed fiber with a numerical aperture NA = 0.33 and corresponding spot size of 2.5 ± 0.5 μm is used to couple the light into the waveguide by the end-fire coupling method. The electrical connection to each nanowire is provided by two rf μ-probes, mounted on piezo towers. Electrical contacts are interfaced to room temperature electronics with 50Ω matched feedthrough. The signal is led through a bias tee and amplified either by 60 dB for each of the channels before being sent to the pulse counter or by 45 dB before being sent to the oscilloscope or the time-correlated single photon counting (TCSPC) module for intensity correlation measurements.

![Current-voltage (IV) curve of the detectors](image)

**Fig. 2.** Current-voltage (IV) curve of the detectors (D1, D2: see Fig. 1) on the same waveguide.

The two detectors show very similar behavior in terms of their current-voltage (IV) characteristics. As depicted in Fig. 2, both detectors have a critical current Iₖ = 23 μA at the measurement base temperature. Critical current density Jₖ is ranging between 3.4 - 3.9 MA/cm² for 50 μm long two-nanowire meanders.

Under illumination, photoresponse pulses with a 1/e decay time of τ₁/e = 1.5 ns are measured which is approximately in agreement with the calculated value τ₁/e = Lₖin/Rₗoad = 1.8 ns [21], based on the kinetic inductance per square reported in Ref [22]. The difference is assigned to the different film thicknesses which is thicker for our detectors as compared to the Ref [22].

Figure 3 shows the device quantum efficiency (QE) of both detectors measured using a continuous-wave laser at 1300 nm in the TE polarization. The two detectors show very similar QE vs bias current dependences, and the peak QE value reaches to 0.5% (D1) and 0.9% (D2) at Iₖ = 0.99Iₖ. This value has been derived by dividing the number of counts (after subtracting the dark counts) by the number of photons coupled to the waveguide, taking into account the...
measured coupling efficiency $\eta = 16.6\%$ and 19\% for the quasi-TE and quasi-TM modes, respectively. Coupling efficiencies are determined by measuring the spectral fringes in the transmission spectra of test waveguides without NbN nanowires [6]. The dark count rate (not shown) is relatively high (~80 kHz at $I_b = 0.95I_c$) in our measurement set-up due to the non-ideal temperature and infrared background radiation but it can be reduced to <100 Hz at $I_b = 0.95I_c$ by lowering the temperature to ~1 K and better shielding of the infrared background [6]. Moreover, as shown in the inset of Fig. 3, the detectors are polarization-independent which can be attributed to the very high absorptance of the 50 µm-long wires for both polarizations. The relatively low value of the device QE, despite the high absorptance, is attributed to the limited internal QE (ratio of detected to absorbed photons) as also indicated by the unsaturated bias dependence of the QE. This is probably related to the film thickness (5.9 nm), larger than the conventional thickness used in nanowire detectors (4-5 nm).

Moreover, the quality of this NbN film is also not optimized, as indicated by the $T_c$, lower than previous demonstration of NbN SSPDs on GaAs [19]. We anticipate that the QE may also be increased using narrower wires [10,23].

4. Crosstalk analysis and second-order intensity correlation measurement

The close packing of the nanowires, needed to ensure equal coupling to the guided light and high absorptance, may produce electrical, magnetic or thermal coupling between the two detectors. That potentially leads to either a false detection or a decreased detection probability in one wire after the other has fired. Such coupling, which we will refer to as crosstalk in the following, would introduce spurious correlations at and around zero delays and affect the measurement of the second-order correlation function. In an ideal autocorrelator, the detectors should work independently without causing any modified/false response arising from the firing adjacent detector [14,24]. Therefore, it is of utmost importance to investigate any possible crosstalk-related limitation of our integrated autocorrelator.
Several tests are performed in order to investigate the possible crosstalk between two adjacent detectors on a single ridge waveguide. A first series of tests is performed in static conditions, to determine whether the bias condition of one detector has an influence on the electro-optical response of the other. Static coupling would mainly result from the thermal or magnetic interaction (intrinsic) as well as the coupling of two detectors due to the shared ground (extrinsic). We studied the electrical and optical response of one detector as a function of the bias of the adjacent detector. Figure 4(a) shows the IV characteristic of D1 (see Fig. 3) while D2 is unbiased. Figure 4(b) and Fig. 4(c) show the IV characteristics of D2 measured with D1 biased at the points indicated with the open squares in Fig. 4(a). In Fig. 4(b), all the curves are superposed while in the blow-up of Fig. 4(c) only small fluctuations (~0.10 μA) in the critical current are observed and reported in Fig. 4(d) as a function of the bias voltage of D1. It can be seen that even when the neighboring detector D1 becomes resistive, where it dissipates the Joule heating to the GaAs lattice, no change of the $I_c$ of D2 is observed within the uncertainty (0.2%) due to stability of the experiment (see Fig. 4(d)). The same behavior is observed for the measurements by sweeping the bias voltage of D2 while measuring the IV for D1. Therefore, no static coupling between the detectors is evidenced.

This is different than the results obtained on sapphire [14] where biasing one detector in the resistive state led to a 10% decrease in the critical current of the other detector. This may be related to the higher thermal conductivity of GaAs with respect to sapphire, leading to an efficient heat transport to the substrate.

Similarly, considering the fact that the dark count rate (DCR) is very sensitive to any change, the DCR was measured for the detector D1 at several bias conditions by sweeping the bias of D2 in the superconducting and unstable region (green dots and black stars in the inset of Fig. 5 that shows the IV curve of D2 when amplifiers are connected). If switching of D2
resulted in any false counts on D1, the dark count rate of D1 would change when D2 is biased in the unstable region. Figure 5 shows the DCR of D1, biased at constant current \( I_b = 0.95-0.99I_c \) while the bias of D2 is swept. There is no measurable variation of the DCR with the bias of the other detector. That confirms that there is no measurable static coupling between two integrated WSPDs.

![Fig. 5. The dark count rate of D1 as a function of the bias current of D2. Even when the critical current of D2 is overcome (shown by light pink, light blue and dark yellow stars folded on the original curve), the count rate of D1 does not change significantly. Inset: The IV curve of D2 where green dots show the D2 bias points in the superconducting region for which the dotted data points in the main panel are taken and the black stars show the bias points in the unstable region (colored stars in the main panel).](image_url)

We then studied dynamic crosstalk, i.e. a temporal variation of the detection probability of one detector due to the firing of the other detector. To this aim, we measured the intensity correlation function \( g^{(2)}(\tau) \) of both CW and pulsed laser coupled to the waveguide. As a coherent beam has a constant \( g^{(2)}(\tau) \), any variation observed at small delays would indicate a spurious increase or decrease of the detection probability upon firing of the adjacent detector. The expected time range for crosstalk is within a few ns delay because the relevant timescales are the time for the formation and the decay of the hotspot (tens of ps) [25,26], the recovery time of the detector (~5 ns) [6], the electromagnetic wave travelling time between the nanowires and along the waveguide (<1 ps) as well as the propagation time of phonons across the entire detector length and between the adjacent pairs (up to a few ps).

The coincidence counts between the two detectors are measured by sending their outputs to the inputs of a correlation card (PicoHarp 300). The zero delay is calibrated in a subsequent experiment by measuring the zero-crossing of a single detector, using the same delay line. In Fig. 6, the coincidence counts are shown as a function of the delay time between the start and the stop channels for a CW light with an excitation power of 77 pW at 1300 nm at \( I_b = 0.97I_c \) (blue line) and \( I_b = 0.99I_c \) (green line). The change in the bias current modifies the number of coincidences due to the varying efficiency of the detectors (see Fig. 3). In order to improve the signal to noise ratio and to clearly observe the coincidences around zero delay, the data is averaged over a 1 ns temporal window (black lines). Even when the bias current of each
detector is brought very close to $I_c$, no trace of crosstalk has been observed in the vicinity of zero delay.

![Fig. 6. Measured intensity correlation histograms for a 1300 nm CW laser with 77 pW excitation power. The detectors are biased at 99% (green line) and 97% (blue line) of their critical current. The black lines show the averaging of the data over 1 ns.](image)

As a further test, we carried out the same experiment with a pulsed laser at 1064 nm and with 5.6 ps-long pulses and a $63 \pm 0.5$ MHz repetition rate. Figure 7 presents the coincidence rate as a function of time delay, measured at varying bias conditions of the two detectors. The detectors are biased with a current from 0.95$I_c$ to 0.99$I_c$ and data is collected for long enough to provide a high number of coincidences for the analysis and then divided by integration time to obtain the coincidence rate. In this situation, coincidences are observed only at delays multiple of the repetition period of the laser (15.9 ± 0.1 ns). The total coincidences with a 2 ns ($\pm 1$ ns for each side) time window around each peak are calculated and shown in Fig. 7 on the right axis and fitted with a linear curve (dashed lines). The linear fit is an approximation for the exponential decay due to the expected saturation of the coincidences vs delay, related to the relatively high count rate in this experimental condition. In order to estimate the error bar we calculate the standard deviation of the data points at delays different than zero with respect to the value given by the linear fit. For all currents, the measured coincidences at zero delay fall within the expected interval as defined by the linear fit and the error bar, showing the absence of crosstalk within our experimental accuracy of max ~4% at 0.97-0.99$I_c$.

Finally, we can determine the timing resolution (jitter) from the second-order intensity correlation measurements. A total jitter of 125 ps is measured, defined as the full-width at half-maximum (FWHM) of the Gaussian distribution at zero delay, for all bias currents between 0.94$I_c$ and 0.99$I_c$. The jitter is the convolution of all the jitters in the measurement set-up. As the jitter of the laser and the correlation card are negligible, we only consider two detectors with an equal timing jitter (amplifiers and the cabling are not excluded) [27]. A jitter of 88 ps (FWHM) is obtained for each detector.
5. Conclusion

In conclusion, the first waveguide autocorrelators have been fabricated and measured with no crosstalk in both static and dynamic regimes within our measurement accuracy, which makes them promising candidates for on-chip autocorrelators. That allows successfully performing on-chip second-order intensity correlation measurements. As a proof of principle, the $g^{(2)}(\tau)$ of CW and pulsed light sources is measured with total temporal resolution of 125 ps (FWHM). Moreover, the detectors are shown to be polarization independent.

These waveguide autocorrelators are also the first step towards integrated photon number resolving (PNR) detectors which could be realized by connecting the different wires together in a parallel [15] or series [16] configuration. The absence of crosstalk is an essential feature for such PNR detectors whose fidelity would otherwise be affected.

Acknowledgments

This work was financially supported by the Dutch Technology Foundation STW, applied science division of NWO, the Technology Program of the Ministry of Economic Affairs, the European Commission through FP7 QUANTIP (Contract No. 244026) and Q-ESSENCE (Contact No. 248095). Part of the nanofabrication was carried out in the NanoLab@TU/e cleanroom facility.